Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | TSUJITA ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0020484	02-2002	Feist et al.	156/196
	В	US-6,309,729 B1	10-2001	Glushko et al.	428/64.1
	ပ	US-6,280,811 B1	08-2001	Nee, Han H.	428/64.1
	D	US-5,876,823 A	03-1999	Nagashima, Michiyoshi	428/64.1
	Ε	US-5,702,792	12-1997	lida et al.	428/64.1
	F	US-			
	G	US-		•	
	Н	US-			
	_	US-		,	
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
	N	JP 10143924 A	05-1998	Japan	KOBAYASHI, MASAKAZU		
	0	(With Trans)	e tion)				
	Р	-					
	Q						
	R						
	S						
	Т						

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	w					
	х					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.